

Notice of References Cited	Application/Control No. 10/786,004		Applicant(s)/Patent Under Reexamination OWEN ET AL.	
	Examiner MUKTESH G. GUPTA		Art Unit 4121	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0174178 A1	11-2002	Stawikowski, Jean-Marie	709/203
*	B	US-6,732,167 B1	05-2004	Swartz et al.	709/223
*	C	US-2005/0044197 A1	02-2005	Lai, Ray Y.	709/223
*	D	US-2005/0038867 A1	02-2005	Henderson et al.	709/217
*	E	US-6,934,756 B2	08-2005	Maes, Stephane H.	709/227
*	F	US-2006/0036682 A1	02-2006	Fletcher et al.	709/203
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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